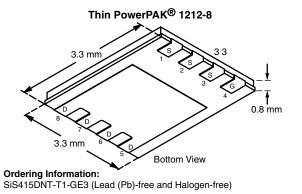


Vishay Siliconix

# P-Channel 20-V (D-S) MOSFET

PRODU	DUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω) Max.	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
	0.0040 at V <sub>GS</sub> = - 10 V	- 35 <sup>a</sup>				
- 20	0.0055 at V <sub>GS</sub> = - 4.5 V	- 35 <sup>a</sup>	55.5 nC			
	0.0095 at V <sub>GS</sub> = - 2.5 V	- 35 <sup>a</sup>				



### **FEATURES**

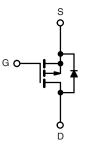
- TrenchFET® Gen III P-Channel Power MOSFET
- Thin 0.8 mm max. height
- 100 % R<sub>q</sub> and UIS Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



COMPLIANT HALOGEN **FREE** 

### **APPLICATIONS**

- Smart Phones, Tablet PCs, and Mobile Computing
  - Battery Switch
  - Load Switch
  - Power Management



P-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	$V_{DS}$	- 20	V		
Gate-Source Voltage		V <sub>GS</sub>	± 12	V	
	T <sub>C</sub> = 25 °C		- 35 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 35 <sup>a</sup>		
Continuous Diam Current (1) = 100 °C)	T <sub>A</sub> = 25 °C	'D	- 22.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 18.2 <sup>b, c</sup>	Α	
Pulsed Drain Current (t = 300 μs)	·	I <sub>DM</sub>	- 80	^	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	- 35 <sup>a</sup>		
Continuous Cource Brain Blode Guirent	T <sub>A</sub> = 25 °C	'S	- 3.3 <sup>b, c</sup>	İ	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 20		
Single Pulse Avalanche Energy	L = 0.1 IIII1	E <sub>AS</sub>	20	mJ	
	$T_C = 25  ^{\circ}C$		52		
Maximum Power Dissipation	$T_C = 70  ^{\circ}C$	В	33	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	3.7 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		2.4 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur	· ·	260			

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	26	33	°C/W
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	1.9	2.4	O/ VV

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 81 °C/W.

## SiS415DNT

# Vishay Siliconix



<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, unless otherwise noted)									
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit			
Static									
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V			
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 14		\//0C			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	ι <sub>D</sub> = - 250 μΑ		3.1		mV/°C			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1.5	V			
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA			
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0 V			- 1	μΑ			
		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10	·			
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α			
		-	do E		0.0040				
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 15 A		0.0044	0.0055	Ω			
		$V_{GS} = -2.5 \text{ V}, I_D = -10 \text{ A}$		0.0076	0.0095	<u>l                                    </u>			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -20 \text{ A}$		70		S			
Dynamic <sup>b</sup>									
Input Capacitance	C <sub>iss</sub>			5460		pF			
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		645					
Reverse Transfer Capacitance	C <sub>rss</sub>			642					
Total Gate Charge	Q <sub>g</sub> Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -10 \text{ A}$		117	180	nC			
Total date onlinge				55.5	85				
Gate-Source Charge		$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$		7.9					
Gate-Drain Charge	$Q_gd$			12.7					
Gate Resistance	$R_g$	f = 1 MHz	0.4	2.2	4	Ω			
Turn-On Delay Time	t <sub>d(on)</sub>			37	70				
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 1 $\Omega$		38	70				
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		82	150				
Fall Time	t <sub>f</sub>			25	50	20			
Turn-On Delay Time	t <sub>d(on)</sub>			14	25	ns			
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 10 V, $R_L$ = 1 $\Omega$		13	25				
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 10 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		83	150				
Fall Time	t <sub>f</sub>			14	25				
Drain-Source Body Diode Characteristi	cs			•	l .				
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 35	Α			
Pulse Diode Forward Current I <sub>SM</sub>					- 80	^			
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = - 4 A, V <sub>GS</sub> = 0 V		- 0.72	- 1.1	V			
Body Diode Reverse Recovery Time	t <sub>rr</sub>			25	50	ns			
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 10 A dl/dt 100 A/:- T 05 00		12	24	nC			
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		11		ns			
		l l							

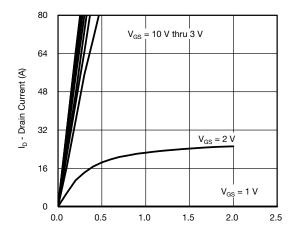
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$ 

b. Guaranteed by design, not subject to production testing.

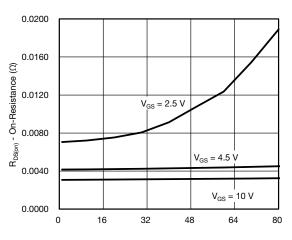


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



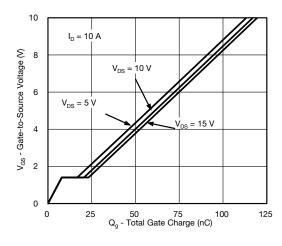
V<sub>DS</sub> - Drain-to-Source Voltage (V)

### **Output Characteristics**

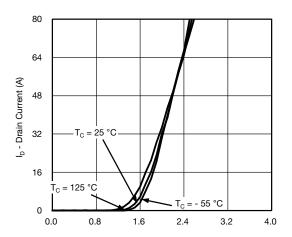


I<sub>D</sub> - Drain Current (A)

### On-Resistance vs. Drain Current and Gate Voltage

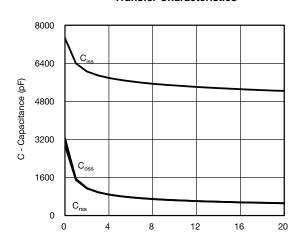


**Gate Charge** 



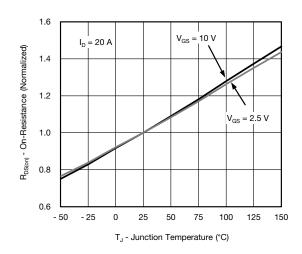
V<sub>GS</sub> - Gate-to-Source Voltage (V)

### **Transfer Characteristics**



V<sub>DS</sub> - Drain-to-Source Voltage (V)

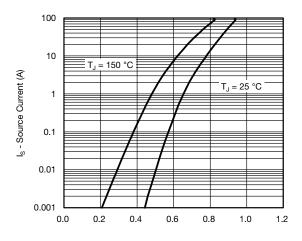
### Capacitance



On-Resistance vs. Junction Temperature

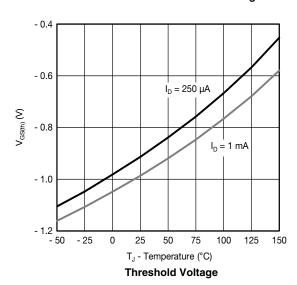
# Vishay Siliconix

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



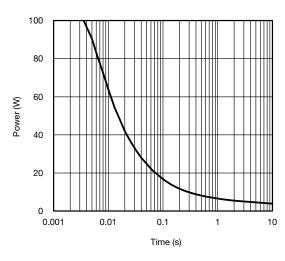
V<sub>SD</sub> - Source-to-Drain Voltage (V)

### Soure-Drain Diode Forward Voltage

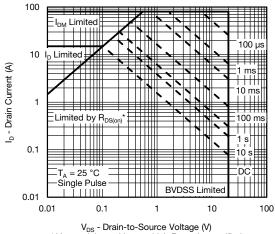


0.020 0.016 - On-Resistance (Ω) 0.012 0.008 R<sub>DS(on)</sub> T<sub>J</sub> = 125 °C 0.004  $T_J = 25 \, ^{\circ}C$ 0.000 8 0 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

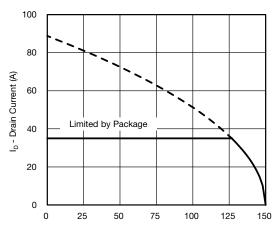


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

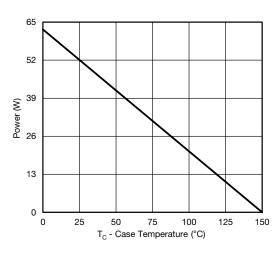


### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

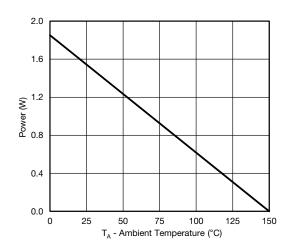


T<sub>C</sub> - Case Temperature (°C)

### **Current Derating\***





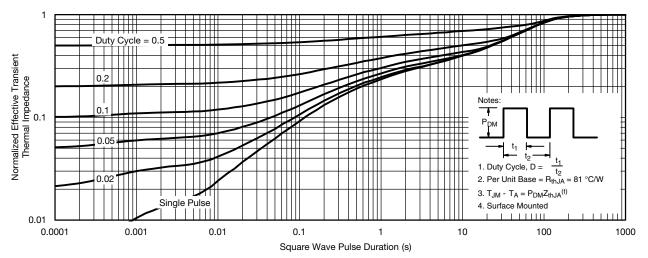


Power Derating, Junction-to-Ambient

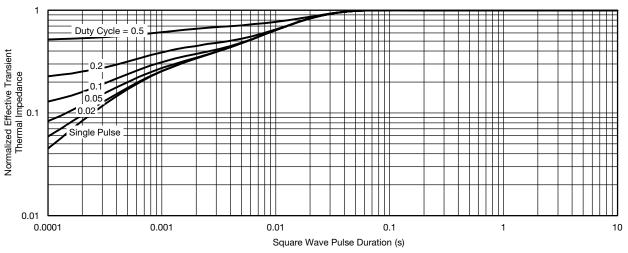
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

# Vishay Siliconix

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



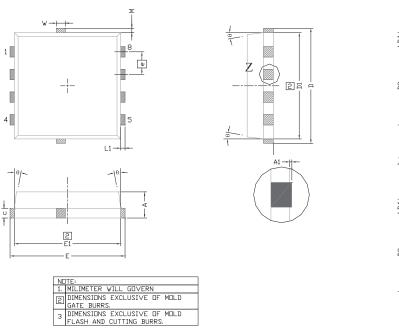
Normalized Thermal Transient Impedance, Junction-to-Case

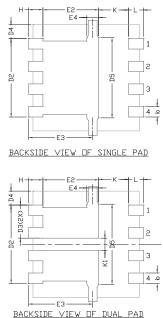
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?63684.





# PowerPAK® 1212-8T





		MILLIMETERS			INCHES		
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
А	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.23	0.30	0.41	0.009	0.012	0.016	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	3.20	3.30	3.40	0.126	0.130	0.134	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
D3	0.48	-	0.89	0.019	-	0.035	
D4		0.47 TYP.		0.0185 TYP.			
D5		2.3 TYP.		0.090 TYP.			
Е	3.20	3.30	3.40	0.126	0.130	0.134	
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	1.75	1.85	1.98	0.069	0.073	0.078	
E4	0.34 TYP.			0.013 TYP.			
е		0.65 BSC			0.026 BSC		
K		0.86 TYP.		0.034 TYP.			
K1	0.35	=	-	0.014	-	-	
Н	0.30	0.41	0.51	0.012	0.016	0.020	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 TYP.				0.005 TYP.		

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DWG: 6012

Revison: 18-Feb-13 Document Number: 62836



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Vishay

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Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as RoHS-Compliant fulfill the definitions and restrictions defined under Directive 2011/65/EU of The European Parliament and of the Council of June 8, 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (EEE) - recast, unless otherwise specified as non-compliant.

Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as Halogen-Free follow Halogen-Free requirements as per JEDEC JS709A standards. Please note that some Vishay documentation may still make reference to the IEC 61249-2-21 definition. We confirm that all the products identified as being compliant to IEC 61249-2-21 conform to JEDEC JS709A standards.

Revision: 02-Oct-12 Document Number: 91000